

N-Channel MOSFET

Applications:

- Adaptor
- Charger
- .SMPS

Lead Free Package and Finish

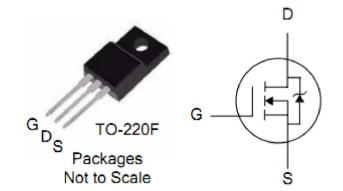
V_{DSS}	R _{DS(ON)} (Typ.)	I _D
650V	0.86Ω	10A

Features:

- RoHS Compliant
- Low ON Resistance
- Low Gate Charge
- Peak Current vs Pulse Width Curve
- Inductive Switching Curves

Ordering Information

PART NUMBER	PACKAGE	BRAND
ITA10N65R	TO-220F	IPS



Absolute Maximum Ratings $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	ITA10N65R	Units
V _{DSS}	Drain-to-Source Voltage	650	V
I _D	Continuous Drain Current	10	Α
I _{DM}	Pulsed Drain Current, V _{GS} @10V (NOTE *2)	40	Α
Б	Power Dissipation	40	W
P_D	Derating Factor above 25℃	0.32	W/℃
V _{GS}	Gate-to-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy (L=10mH)	500	mJ
T _L	Maximum Temperature for Soldering	300	
T _J and T _{STG}	Operating Junction and Storage Temperature Range (NOTE *1)	150,-55 to150	$^{\circ}$ C

Thermal Resistance

Symbol	Parameter	Тур.	Units	Test Conditions
В	R _{B.IC} Junction-to-Case 3.13		Water cooled heatsink, P _D adjusted for a	
$R_{\theta JC}$	Junction-to-Case	3.13	°C XW	peak junction temperature of +150℃.
$R_{\theta JA}$	Junction-to-Ambient	62.5		1 cubic foot chamber, free air.



OFF Characteristics $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	650			V	V _{GS} =0V, I _D =250μA
	Drain to Source Leakage Current			1		V_{DS} =650V, V_{GS} =0V T_{J} =25 $^{\circ}$ C
I _{DSS}	Drain-to-Source Leakage Current			100	μA	V _{DS} =520V, V _{GS} =0V T _J =125°C
1	Gate-to-Source Forward Leakage			+100	nΛ	V _{GS} =+30V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -30V

ON Characteristics T_J=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
В	StaticDrain-to-Source		0.06		Ω	V_{GS} =10V, I_{D} =5A
R _{DS(ON)}	On-Resistance(NOTE *3)		0.86	I		
$V_{GS(TH)}$	Gate Threshold Voltage	2		4	V	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$
9 _{fs}	Forward Transconductance(NOTE *3)		9.5		S	V_{DS} =15V, I_{D} =5A

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
C _{iss}	Input Capacitance		1642			
C _{oss}	Output Capacitance		128		pF	V_{GS} = 0V, V_{DS} = 25V f =1.0MHz
C _{rss}	Reverse Transfer Capacitance		7			
Q _g	Total Gate Charge		32			L =10 A \ / = E20\ /
Q_{gs}	Gate-to-Source Charge		8		nC	$I_D = 10A, V_{DD} = 520V$ $V_{GS} = 10V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		12			

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
t _{d(ON)}	Turn-on Delay Time		27		nc	V _{DD} =325V, I _D =10A,
t _{rise}	Rise Time		22			
t _{d(OFF)}	Turn-Off Delay Time		53		ns	V_G =10V R_G =10 Ω
t _{fall}	Fall Time		24			



ITA10N65R

Source-Drain Diode Characteristics Tc=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
	Continuous Source Current			10	^	
Is	(Body Diode)			10	Α	T -25°C
	Maximum Pulsed Current			40	А	T _C =25℃
I _{SM}	(Body Diode)			40		
V _{SD}	Diode Forward Voltage			1.5	V	I _{SD} =10A, V _{GS} =0V
t _{rr}	Reverse Recovery Time		528		ns	I _F = I _S
Q _{rr}	Reverse Recovery Charge		3220		nC	di/dt=100A/us

Notes:

^{*1.} T_J = +25°C to +150°C.

^{*2.} Repetitive rating; pulse width limited by maximum junction temperature.

^{*3.} Pulse width < 380μ s; duty cycle < 2%.



Characteristics Curve:

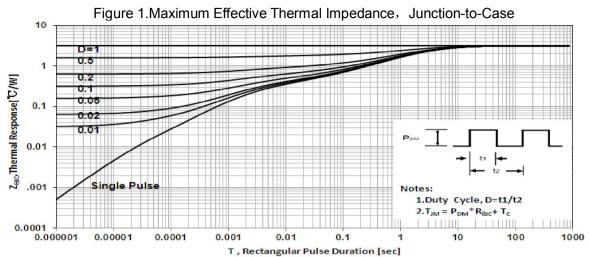


Figure 2. Typical Output Characteristics

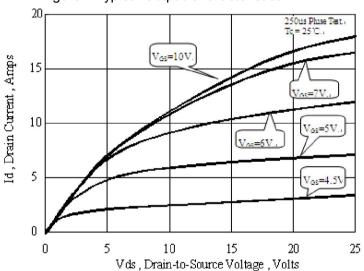


Figure 4. Typical Body Diode Transfer Characteristics

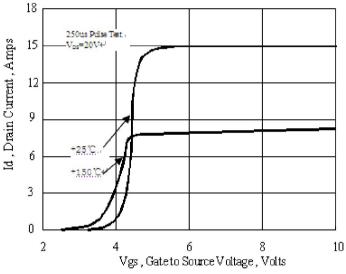
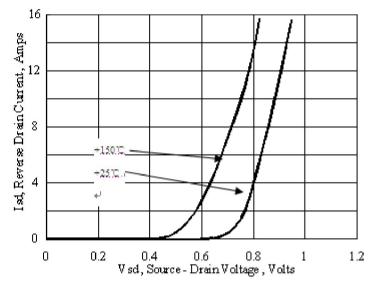


Figure 3. Typical Transfer Characteristics

Figure 5. Typical Drain-to-source on ResistanceVS Drain Current



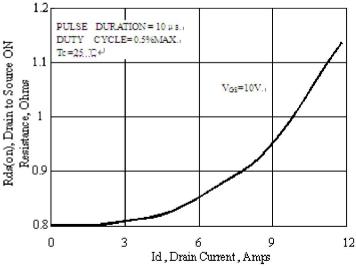






Figure 6. Capacitance VS Drain-to-Source Voltage

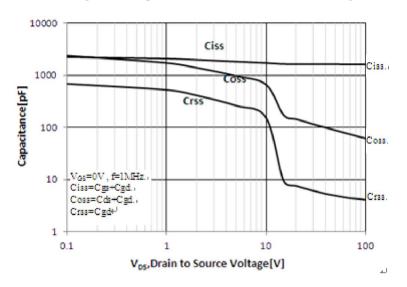


Figure 8. Breakdown Voltage VS Temperature

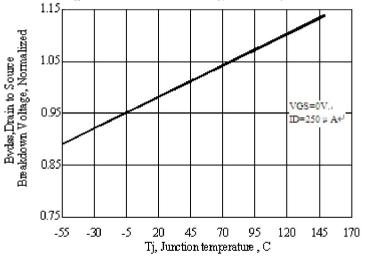


Figure 10. Safe Operating Area

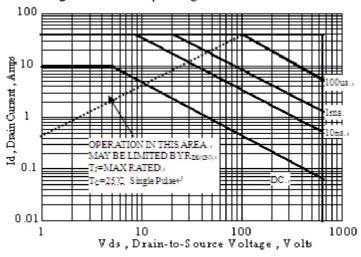


Figure 7. Gate Charge VS Gate-to-Source Voltage

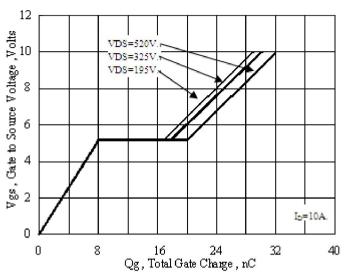
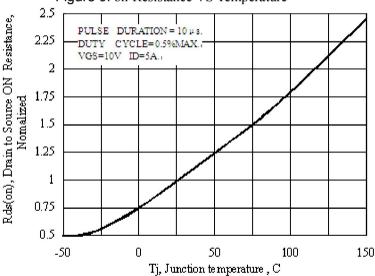


Figure 9. on-Resistance VS Temperature





Test Circuits and Waveforms

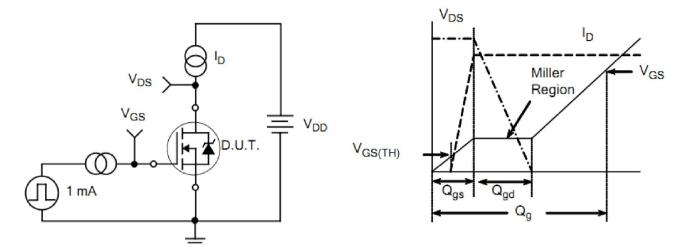


Figure 11. Gate Charge Test Circuit

Figure 12. Gate Charge Waveforms

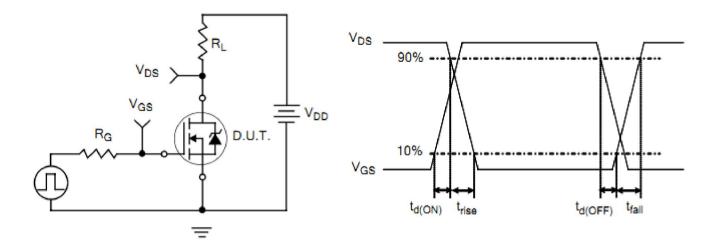


Figure 13. Resistive Switching Test Circuit

Figure 14. Resistive Switching Waveforms



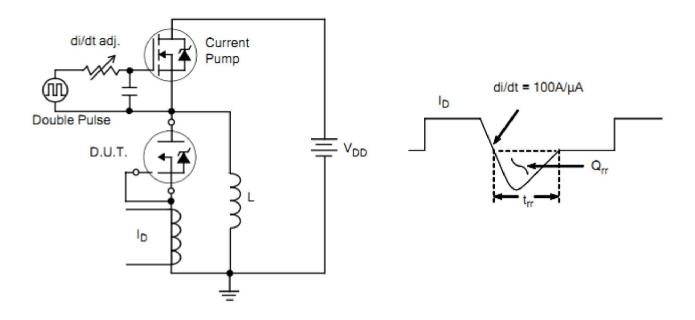


Figure 15. Diode Reverse Recovery Test Circuit

Figure 16. Diode Reverse Recovery Waveform

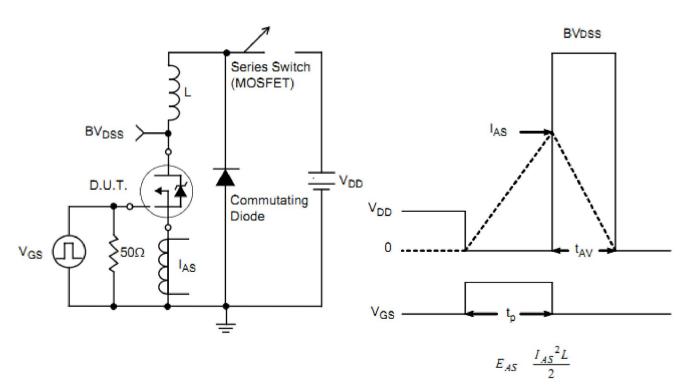


Figure 17. Unclamped Inductive Switching Test Circuit Figure 18. Unclamped Inductive Switching Waveform



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TK31J60W5,S1VQ(O 2SK2614(TE16L1,Q) DMN1017UCP3-7 EFC2J004NUZTDG FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7

NTE2384 NTE2969 NTE6400A DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 SSM6P54TU,LF DMP22D4UFO-7B IPS60R3K4CEAKMA1 DMN1006UCA6-7 DMN16M9UCA6-7 STF5N65M6 STU5N65M6 C3M0021120D DMN13M9UCA6-7

BSS340NWH6327XTSA1 MCM3400A-TP DMTH10H4M6SPS-13 IRF40SC240ARMA1 IPS60R1K0PFD7SAKMA1

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